## Applicant(s)/Patent Under Reexamination 10/643,513 CHEN ET AL. Notice of References Cited Art Unit Examiner Carl H. Layno 8/23/04 Page 1 of 1 3762

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,068,651	05-2000	Brandell, Brian	607/5
	В	US-			
	С	US-			- ""
	D	US-			10.182
	E	US-			
	F	US-			
	G	US-			
	π	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
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	Р						
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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